

N-Channel 600V (D-S) Super Junction Power MOSFET

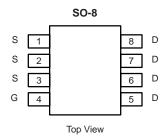
PRODUCT SUMMARY					
V _{DS} (V) at T _J max.	600				
R _{DS(on)} max. at 25 °C (Ω)	$V_{GS} = 10 V$	0.48			
Q _g max. (nC)	38				
Q _{gs} (nC)	4				
Q _{gd} (nC)	4.2				
Configuration	Single				

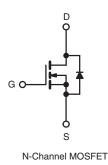
FEATURES

- Low figure-of-merit (FOM) Ron x Qa
- Low input capacitance (Ciss)
- · Reduced switching and conduction losses
- Ultra low gate charge (Q_a)
- Avalanche energy rated (UIS)

APPLICATIONS

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- Lighting
 - High-intensity discharge (HID)
 - Fluorescent ballast lighting
- Industrial





ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	600	v	
Gate-Source Voltage			V _{GS}	± 30	v	
Continuous Drain Current (T 150 °C)	V _{GS} at 10 V	$T_{\rm C} = 25 \ ^{\circ}{\rm C}$ $T_{\rm C} = 100 \ ^{\circ}{\rm C}$	– I _D –	10		
Continuous Drain Current (T _J = 150 °C)	V _{GS} at 10 V	V T _C = 100 °C		6.7	А	
Pulsed Drain Current ^a			I _{DM}	30		
Linear Derating Factor				0.3	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	132	mJ	
Maximum Power Dissipation			PD	31	W	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	-55 to +150	°C	
Drain-Source Voltage Slope	T _J = 125 °C		dV/dt	50	V/ns	
Reverse Diode dV/dt ^d		av/dt	3.1	v/ns		
Soldering Recommendations (Peak Temperature) ^c	for 10 s			300	°C	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature.

b. V_{DD} = 50 V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 4.5 A.

c. 1.6 mm from case.

d. $I_{SD} \leq I_D, \, dI/dt = 100$ A/µs, starting $T_J = 25 \ ^\circ C.$



THERMAL RESISTANCE RATI	NGS							
PARAMETER	SYMBOL	TYP.		MAX.	MAX.		UNIT	
Maximum Junction-to-Ambient	R _{thJA}	-		80		*OAN		
Maximum Junction-to-Case (Drain)	R _{thJC}	- 0.6				°C/W		
SPECIFICATIONS (T _J = 25 $^{\circ}$ C, u	nless otherwi	se noted)						
PARAMETER	SYMBOL	TES	r condit	IONS	MIN.	TYP.	MAX.	UNIT
Static		-				-	-	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D =	250 µA	600	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	$I_D = 1 \text{ mA}$	-	0.65	-	V/°C
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D =	250 µA	2	-	4	V
		$V_{GS} = \pm 20 V$		-	-	± 100	nA	
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 30$	V	-	-	± 1	μA
		V _{DS} = 600 V, V _{GS} = 0 V		-	-	1		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 520 V	V _{DS} = 520 V, V _{GS} = 0 V, T _J = 125 °C		-	-	10	μA
Drain-Source On-State Resistance	R _{DS(on)}	$V_{GS} = 10 V$		I _D = 5 A	-	0.48	-	Ω
Forward Transconductance	g fs	$V_{DS} = 30 \text{ V}, \text{ I}_{D} = 5 \text{ A}$		-	16	-	S	
Dynamic						•		
Input Capacitance	C _{iss}	$V_{GS} = 0 V,$ $V_{DS} = 100 V,$ f = 1 MHz		-	680	-	pF	
Output Capacitance	C _{oss}			-	140	-		
Reverse Transfer Capacitance	C _{rss}			-	5	-		
Effective Output Capacitance, Energy Related ^a	C _{o(er)}	$V_{DS} = 0$ V to 520 V, $V_{GS} = 0$ V		-	63	-		
Effective Output Capacitance, Time Related ^b	C _{o(tr)}			-	113	-		
Total Gate Charge	Qg	V _{GS} = 10 V I _D = 5 A, V _{DS} = 520 V		-	38	56	nC	
Gate-Source Charge	Q _{gs}			-	4	-		
Gate-Drain Charge	Q _{gd}				-	4.5	-	
Turn-On Delay Time	t _{d(on)}			-	13	25		
Rise Time	t _r		V _{DD} = 520 V, I _D = 5 A,		-	11	35	ns
Turn-Off Delay Time	t _{d(off)}	V_{GS} = 10 V, R_g = 9.1 Ω f = 1 MHz, open drain		-	81	90		
Fall Time	t _f			-	25	40		
Gate Input Resistance	Rg	T = 1	whz, ope		-	3.5	-	Ω
Drain-Source Body Diode Characteristic	2S				1	1		1
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	10	А	
Pulsed Diode Forward Current	I _{SM}			-	-	30	n	
Diode Forward Voltage	V _{SD}	$T_{J} = 25 \text{ °C}, I_{S} = 5 \text{ A}, V_{GS} = 0 \text{ V}$		-	-	1.5	V	
Reverse Recovery Time	t _{rr}	1			-	270	-	ns
Reverse Recovery Charge	Q _{rr}	$T_J = 25 \text{ °C}, I_F = I_S = 5 \text{ A},$ dl/dt = 100 A/ μ s, V _R = 400 V		-	3.3	-	μC	
Reverse Recovery Current	I _{RRM}				30	-	A	

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

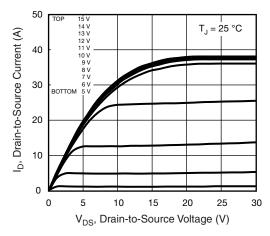


Fig. 1 - Typical Output Characteristics

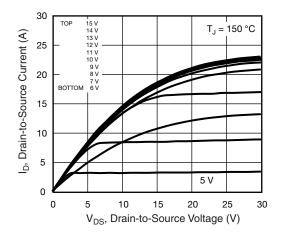


Fig. 2 - Typical Output Characteristics

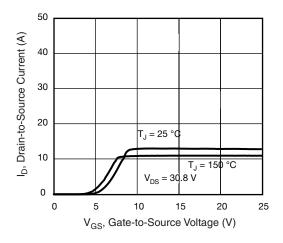


Fig. 3 - Typical Transfer Characteristics

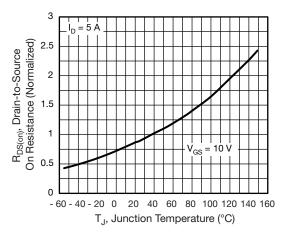


Fig. 4 - Normalized On-Resistance vs. Temperature

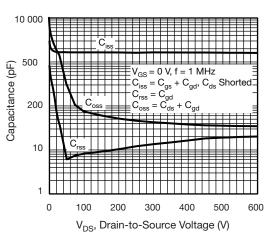


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

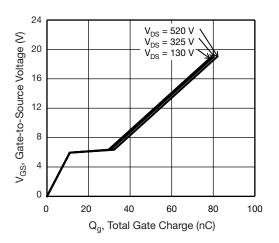


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



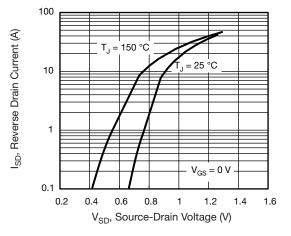
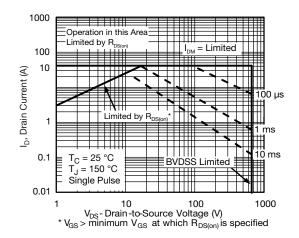


Fig. 7 - Typical Source-Drain Diode Forward Voltage





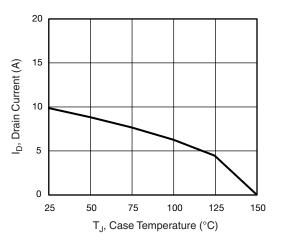


Fig. 9 - Maximum Drain Current vs. Case Temperature

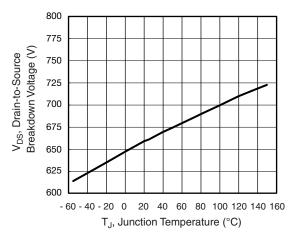


Fig. 10 - Temperature vs. Drain-to-Source Voltage

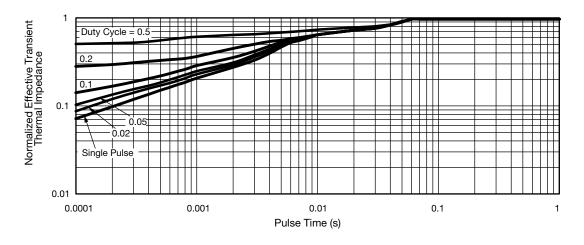


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case

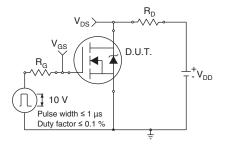


Fig. 12 - Switching Time Test Circuit

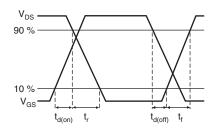


Fig. 13 - Switching Time Waveforms

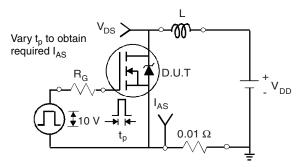


Fig. 14 - Unclamped Inductive Test Circuit

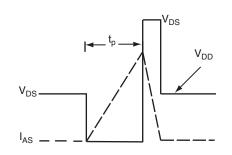


Fig. 15 - Unclamped Inductive Waveforms

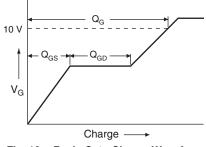


Fig. 16 - Basic Gate Charge Waveform

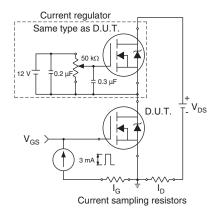


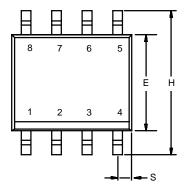
Fig. 17 - Gate Charge Test Circuit

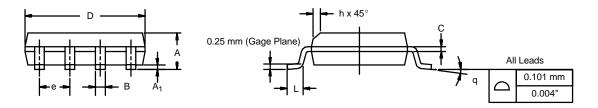


Package Information www.din-tek.jp

SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012

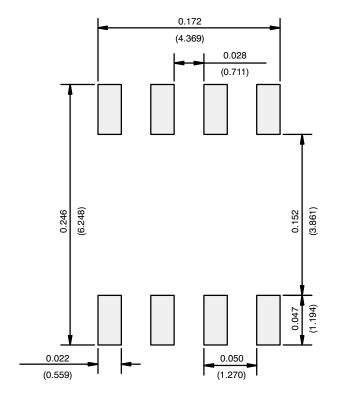




	MILLIMETERS		INC	ES	
DIM	Min	Мах	Min	Max	
A	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
E	3.80	4.00	0.150	0.157	
е	1.27	BSC	0.050 BSC		
н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498					



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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